# **RENESAS** Low Skew, 1-to-16 LVCMOS/LVTTL Clock Generator

# DATASHEET

# **GENERAL DESCRIPTION**

The 87016 is a low skew, 1:16 LVCMOS/LVTTL Clock Generator. The device has 4 banks of 4 outputs and each bank can be independently selected for  $\div$ 1 or  $\div$ 2 frequency operation. Each bank also has its own power supply pins so that the banks can operate at the following different voltage levels: 3.3V, 2.5V, and 1.8V. The low impedance LVCMOS/LVTTL outputs are designed to drive 50 $\Omega$  series or parallel terminated transmission lines.

The divide select inputs, DIV\_SELA:DIV\_SELD, control the output frequency of each bank. The output banks can be independently selected for ÷1 or ÷2 operation. The bank enable inputs, CLK\_ENA:CLK\_END, support enabling and disabling each bank of outputs individually. The CLK\_ENA:CLK\_END circuitry has a synchronizer to prevent runt pulses when enabling or disabling the clock outputs. The master reset input, nMR/OE, resets the ÷1/+2 flip flops and also controls the active and high impedance states of all outputs. This pin has an internal pull-up resistor and is normally used only for test purposes or in systems which use low power modes.

The 87016 is characterized to operate with the core at 3.3V and the banks at 3.3V, 2.5V, or 1.8V. Guaranteed bank, output, and part-to-part skew characteristics make the 87016 ideal for those clock applications demanding well-defined performance and repeatability.

0

0

0

0

# FEATURES

- Sixteen LVCMOS/LVTTL outputs (4 banks of 4 outputs)
- Selectable differential CLK1, nCLK1 or LVCMOS clock input
- CLK1, nCLK1 pair can accept the following differential input levels: LVPECL, LVDS, LVHSTL, SSTL, HCSL
- CLK0 supports the following input types: LVCMOS, LVTTL
- Maximum output frequency: 250MHz
- Independent bank control for ÷1 or ÷2 operation
- Independent output bank voltage settings for 3.3V, 2.5V, or 1.8V operation
- Asynchronous clock enable/disable
- Output skew: 170ps (maximum)
- · Bank skew: 30ps (maximum)
- Part-to-part skew: 750ps (maximum)
- 3.3V core, 3.3V, 2.5V, or 1.8V output operating supply
- 0°C to 85°C ambient operating temperature
- · Available in lead-free RoHS compliant package

# BLOCK DIAGRAM

nMR/OE

CLK0 -

CLK1

nCLK1

CLK\_SEL

DIV SELA

DIV\_SELB

DIV\_SELD -

DIV\_SELC

CLK ENA

CLK\_ENB

CLK\_ENC

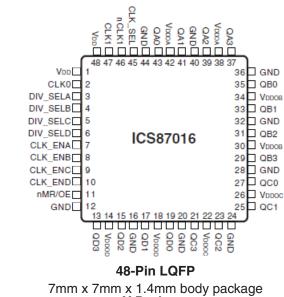


QA0:QA3

OB0:OB3

QC0:QC3

QD0:QD3



Y Package Top View

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## TABLE 1. PIN DESCRIPTIONS

Number	Name	Т	уре	Description
1, 48	V <sub>DD</sub>	Power		Positive supply pins.
2	CLK0	Input	Pulldown	LVCMOS / LVTTL clock input.
3	DIV_SELA	Input	Pullup	Controls frequency division for Bank A outputs. LVCMOS / LVTTL interface levels.
4	DIV_SELB	Input	Pullup	Controls frequency division for Bank B outputs LVCMOS / LVTTL interface levels
5	DIV_SELC	Input	Pullup	Controls frequency division for Bank C outputs. LVCMOS / LVTTL interface levels.
6	DIV_SELD	Input	Pullup	Controls frequency division for Bank D outputs. LVCMOS / LVTTL interface levels.
7	CLK_ENA	Input	Pullup	Output enable for Bank A outputs. Active HIGH. If pin is LOW, outputs drive low. LVCMOS / LVTTL interface levels.
8	CLK_ENB	Input	Pullup	Output enable for Bank B outputs. Active HIGH. If pin is LOW, outputs drive low. LVCMOS / LVTTL interface levels.
9	CLK_ENC	Input	Pullup	Output enable for Bank C outputs. Active HIGH. If pin is LOW, outputs drive low. LVCMOS / LVTTL interface levels.
10	CLK_END	Input	Pullup	Output enable for Bank D outputs. Active HIGH. If pin is LOW, outputs drive low. LVCMOS / LVTTL interface levels.
11	nMR/OE	Input	Pullup	Master reset. When LOW, resets the ÷1/÷2 flip flops and sets the outputs to high impedance. LVCMOS / LVTTL interface levels.
12, 16, 20, 24, 28, 32, 36, 40, 44	GND	Power		Power supply ground.
13, 15, 17, 19	QD3, QD2, QD1, QD0	Output		Bank D outputs. LVCMOS / LVTTL interface levels.
14, 18	V <sub>DDOD</sub>	Power		Output Bank D power supply pins.
21, 23, 25, 27	QC3, QC2, QC1, QC0	Output		Bank C outputs. LVCMOS / LVTTL interface levels.
22, 26	V	Power		Output Bank C power supply pins.
29, 31, 33, 35	QB3, QB2, QB1, QB0	Output		Bank B outputs. LVCMOS / LVTTL interface levels.
30, 34	V <sub>DDOB</sub>	Power		Output Bank B power supply pins.
37, 39, 41, 43	QA3, QA2, QA1, QA0	Output		Bank A outputs. LVCMOS / LVTTL interface levels.
38, 42	V <sub>DDOA</sub>	Power		Output Bank A power supply pins.
45	CLK_SEL	Input	Pulldown	Clock select input. When HIGH, selects CLK1, nCLK1 inputs. When LOW, selects CLK0 input. LVCMOS / LVTTL interface levels.
46	nCLK1	Input	Pullup	Inverting differential clock input.
47	CLK1	Input	Pulldown	Non-inverting differential clock input.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

## TABLE 2. PIN CHARACTERISTICS

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C <sub>IN</sub>	Input Capacitance			4		pF
R <sub>PULLUP</sub>	Input Pullup Resistor			51		kΩ
		$V_{DD}, V_{DDOx} = 3.465V$			18	pF
C <sub>PD</sub>	Power Dissipation Capacitance (per output); NOTE 1	$V_{DD} = 3.465, V_{DDOx} = 2.625V$			20	pF
		$V_{DD} = 3.465, V_{DDOx} = 1.89V$			30	pF
R <sub>out</sub>	Output Impedance			7		Ω

NOTE 1:  $V_{\text{DDOx}}$  denotes  $V_{\text{DDOA}}$ ,  $V_{\text{DDOB}}$ ,  $V_{\text{DDOC}}$ , and  $V_{\text{DDOD}}$ .

### TABLE 3. FUNCTION TABLE

	Inputs		Outputs		
nMR/OE	CLK_ENx	DIV_SELx	Bank X	Qx Frequency	
0	Х	Х	Hi Z	N/A	
1	1	0	Active	fIN/2	
1	1	1	Active	fIN	
1	0	Х	Low	N/A	

### ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V <sub>DD</sub>	4.6V
Inputs, V <sub>I</sub>	-0.5V to V <sub>DD</sub> + 0.5 V
Outputs, V <sub>o</sub>	-0.5V to $V_{\text{DDOx}}$ + 0.5V
Package Thermal Impedance, $\boldsymbol{\theta}_{_{J\!A}}$	47.9°C/W (0 lfpm)
Storage Temperature, T <sub>stg</sub>	-65°C to 150°C

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

### Table 4A. Power Supply DC Characteristics, $V_{DD} = 3.3V \pm 5\%$ , Ta = 0°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V <sub>DD</sub>	Positive Supply Voltage		3.135	3.3	3.465	V
			3.135	3.3	3.465	V
V <sub>DDOx</sub>	Output Supply Voltage; NOTE 1		2.375	2.5	2.625	V
	-		1.71	1.8	1.89	V
I <sub>DD</sub>	Power Supply Current				100	mA
I <sub>DDOx</sub>	Output Supply Current; NOTE 2				15	mA

NOTE 1:  $V_{DDOx}$  denotes  $V_{DDOA}$ ,  $V_{DDOB}$ ,  $V_{DDOC}$ , and  $V_{DDOD}$ . NOTE 2:  $I_{DDOx}$  denotes  $I_{DDOA}$ ,  $I_{DDOB}$ ,  $I_{DDOC}$ , and  $I_{DDOD}$ .

### TABLE 4B. LVCMOS/LVTTL DC CHARACTERISTICS, $V_{DD} = 3.3V \pm 5\%$ , TA = 0°C to 85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V <sub>IH</sub>	Input High Voltage	DIV_SELA:DIV_SELD, CLK_ENA:CLK_END, nMR/OE, CLK_SEL		2		V + 0.3	V
		CLK0		2		V + 0.3	V
V <sub>IL</sub>	Input Low Voltage	DIV_SELA:DIV_SELD, CLK_ENA:CLK_END, nMR/OE, CLK_SEL		-0.3		0.8	V
		CLK0		-0.3		1.3	V
I <sub>IH</sub>	Input High Current	CLK_ENA:CLK_END, DIV_SELA:DIV_SELD, nMR/OE	V = V = 3.465V			5	μA
		CLK0, CLK_SEL	V = V = 3.465V			150	μA
I <sub>IL</sub>	Input Low Current	CLK_ENA:CLK_END, DIV_SELA:DIV_SELD, nMR/OE	V = 3.465V, V = 0V	-150			μA
		CLK0, CLK_SEL	V = 3.465V, V = 0V	-5			μA
			V = 3.3V ± 5%; NOTE 2	2.6			V
V <sub>он</sub>	Output High	Voltage; NOTE 1	V = 2.5V ± 5%; NOTE 2	1.8			V
• он			V = 1.8V ± 5%; NOTE 2 I = -2mA	V <sub>DDOx</sub> - 0.45			V
			V = 3.3V ± 5%; NOTE 2			0.5	V
V <sub>ol</sub>	Output Low V	oltage; NOTE 1	V = 2.5V ± 5%; NOTE 2			0.5	V
* OL			V = 1.8V ± 5%; NOTE 2 I = 2mA			0.45	V
I <sub>ozl</sub>	Output Tristat	te Current Low		-5			μA
I <sub>ozh</sub>	Output Tristat	te Current High				5	μA

NOTE 1: Outputs terminated with 50W to  $V_{DDOX}/2$ . See Parameter Measurement Information, Output Load Test Circuit. NOTE 2:  $V_{DDOx}$  denotes  $V_{DDOA}$ ,  $V_{DDOB}$ ,  $V_{DDOD}$ , and  $V_{DDOD}$ .

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
	Input High Current	nCLK1	$V_{IN} = V_{DD} = 3.465V$			5	μA
'н		CLK1	$V_{IN} = V_{DD} = 3.465V$			150	μA
	Input Low Current	nCLK1	$V_{IN} = 0V, V_{DD} = 3.465V$	-150			μA
'IL		CLK1	$V_{IN} = 0V, V_{DD} = 3.465V$	-5			μA
V <sub>PP</sub>	Peak-to-Peak Input	Voltage		0.15		1.3	V
V <sub>CMR</sub>	Common Mode Inpu NOTE 1, 2	ut Voltage;		GND + 0.5		V <sub>DD</sub> - 0.85	V

### TABLE 4C. DIFFERENTIAL DC CHARACTERISTICS, $V_{DD} = 3.3V \pm 5\%$ , TA = 0°C to 85°C

NOTE 1: For single ended applications, the maximum input voltage for CLK1, nCLK1 is  $V_{DD}$  + 0.3V. NOTE 2: Common mode voltage is defined as  $V_{H}$ .

#### TABLE 5A. AC CHARACTERISTICS, $V_{DD} = V_{DDOx} = 3.3V \pm 5\%$ , TA = 0°C to 85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f <sub>MAX</sub>	Output Frequency					250	MHz
	Propagation Delay	CLK0; NOTE 1A		2.8	3.2	3.7	ns
tp <sub>LH</sub>	Propagation Delay, Low to High	CLK1, nCLK1; NOTE 1B		2.9	3.4	3.9	ns
<i>t</i> sk(b)	Bank Skew; NOTE 2, 7		Measured on the Rising Edge			30	ps
<i>t</i> sk(o)	Output Skew; NOTE	3, 7	Measured on the Rising Edge			150	ps
<i>t</i> sk(pp)	Part-to-Part Skew; N	NOTE 5, 7				750	ps
t <sub>R</sub> / t <sub>F</sub>	Output Rise/Fall Tim	ne; NOTE 6	20% to 80%	200		700	ps
a da			f < 175MHz	45		55	%
odc	Output Duty Cycle		f ≥ 175MHz	40		60	%
t <sub>en</sub>	Output Enable Time	; NOTE 6				10	ns
t <sub>DIS</sub>	Output Disable Time	; NOTE 6				10	ns

All parameters measured at 250MHz unless noted otherwise.

NOTE 1A: Measured from the  $V_{\mbox{\tiny DD}}/2$  of the input to  $V_{\mbox{\tiny DDOX}}/2$  of the output.

NOTE 1B: Measured from the differential input crossing point to  $V_{\text{DDDX}}$ /2 of the output.

NOTE 2: Defined as skew within a bank with equal load conditions.

NOTE 3: Defined as skew between outputs at the same supply voltage and with equal load conditions.

Measured at V<sub>DDOX</sub>/2.

NOTE 4: Defined as skew across banks of outputs switching in the same direction operating at different frequencies with the same supply voltages and equal load conditions. Measured at  $V_{DDOX}/2$ .

NOTE 5: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at V<sub>DDOX</sub>/2.

NOTE 6: These parameters are guaranteed by characterization. Not tested in production.

NOTE 7: This parameter is defined in accordance with JEDEC Standard 65.

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f <sub>MAX</sub>	Output Frequency					250	MHz
	Propagation Delay,	CLK0; NOTE 1A		2.9	3.3	3.8	ns
tp <sub>LH</sub>	Low to High	CLK1, nCLK1; NOTE 1B		3	3.5	4	ns
<i>t</i> sk(b)	Bank Skew; NOTE 2, 7		Measured on the Rising Edge			30	ps
<i>t</i> sk(o)	Output Skew; NOTE 3, 7		Measured on the Rising Edge			160	ps
<i>t</i> sk(pp)	Part-to-Part Skew; N	IOTE 5, 7				750	ps
t <sub>R</sub> /t <sub>F</sub>	Output Rise/Fall Tim	ie; NOTE 6	20% to 80%	200		700	ps
ada	Outrast Duty Ovala		f < 175MHz	45		55	%
odc	Output Duty Cycle		f ≥ 175MHz	40		60	%
t <sub>en</sub>	Output Enable Time	; NOTE 6				10	ns
t <sub>DIS</sub>	Output Disable Time	; NOTE 6				10	ns

TABLE 5B. AC CHARACTERISTICS,  $V_{DD} = 3.3V \pm 5\%$ ,  $V_{DDOx} = 2.5V \pm 5\%$ , TA = 0°C to 85°C

All parameters measured at 250MHz unless noted otherwise.

NOTE 1A: Measured from the  $V_{DD}/2$  of the input to  $V_{DDOX}/2$  of the output. NOTE 1B: Measured from the differential input crossing point to  $V_{DDOX}/2$  of the output.

NOTE 2: Defined as skew within a bank with equal load conditions.

NOTE 3: Defined as skew between outputs at the same supply voltage and with equal load conditions.

Measured at  $V_{\text{DDOX}}/2$ .

NOTE 4: Defined as skew across banks of outputs switching in the same direction operating at different frequencies with the same supply voltages and equal load conditions. Measured at  $V_{\text{DDOX}}/2$ .

NOTE 5: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at V<sub>DDOX</sub>/2.

NOTE 6: These parameters are guaranteed by characterization. Not tested in production.

NOTE 7: This parameter is defined in accordance with JEDEC Standard 65.

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f <sub>MAX</sub>	Output Frequency					250	MHz
	Propagation Delay, CLK0; NOTE 1A			3.1	3.8	4.5	ns
tp <sub>LH</sub>	Low to High	CLK1, nCLK1; NOTE 1B		3.1	3.8	4.5	ns
<i>t</i> sk(b)	Bank Skew; NOTE 2, 7		Measured on the Rising Edge			30	ps
<i>t</i> sk(o)	Output Skew; NOTE 3, 7		Measured on the Rising Edge			170	ps
<i>t</i> sk(pp)	Part-to-Part Skew; N	IOTE 5, 7				750	ps
t <sub>R</sub> / t <sub>F</sub>	Output Rise/Fall Tim	ie; NOTE 6	20% to 80%	200		700	ps
ada	Outrast Duty Ovala		f < 175MHz	45		55	%
odc	Output Duty Cycle		f ≥ 175MHz	40		60	%
t <sub>en</sub>	Output Enable Time	; NOTE 6				10	ns
t <sub>DIS</sub>	Output Disable Time	; NOTE 6				10	ns

### TABLE 5C. AC CHARACTERISTICS, $V_{DD} = 3.3V \pm 5\%$ , $V_{DDOx} = 1.8V \pm 5\%$ , TA = 0°C to 85°C

All parameters measured at 250MHz unless noted otherwise.

NOTE 1A: Measured from the V<sub>DD</sub>/2 of the input to V<sub>DDOX</sub>/2 of the output. NOTE 1B: Measured from the differential input crossing point to V<sub>DDOX</sub>/2 of the output.

NOTE 2: Defined as skew within a bank with equal load conditions.

NOTE 3: Defined as skew between outputs at the same supply voltage and with equal load conditions.

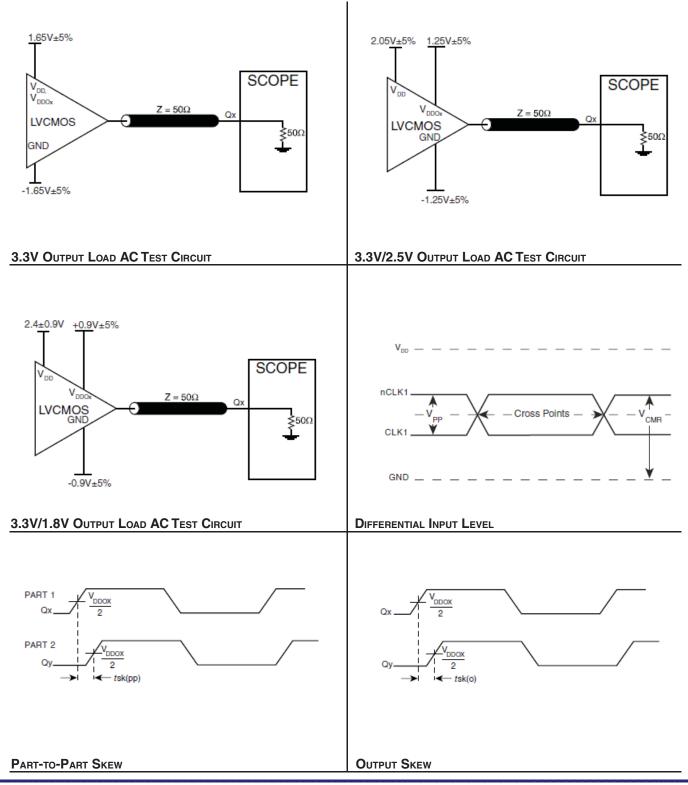
Measured at  $V_{\text{DDOX}}/2$ .

NOTE 4: Defined as skew across banks of outputs switching in the same direction operating at different frequencies with the same supply voltages and equal load conditions. Measured at  $V_{\mbox{\tiny DDOX}}/2.$ 

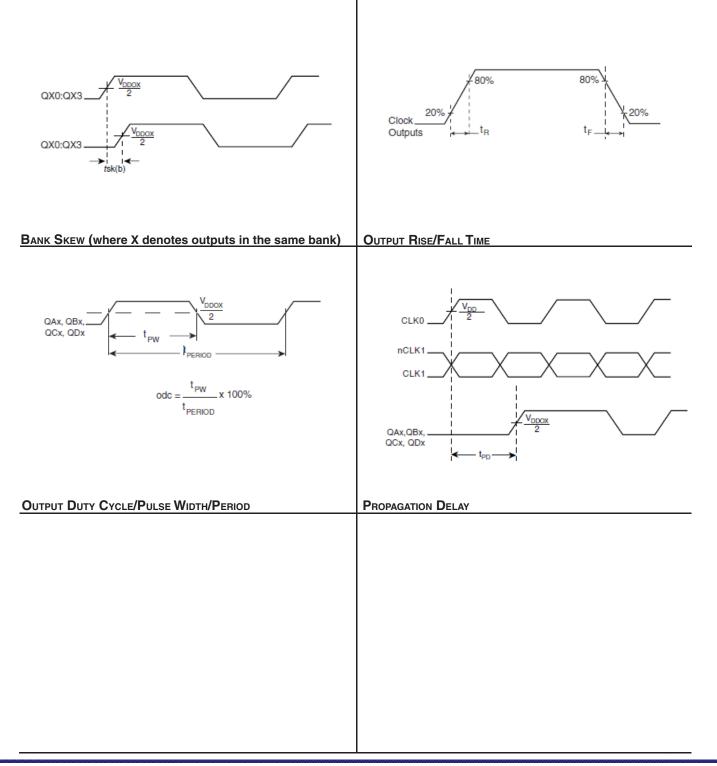
NOTE 5: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at  $V_{\text{DDOX}}/2$ .

NOTE 6: These parameters are guaranteed by characterization. Not tested in production.

NOTE 7: This parameter is defined in accordance with JEDEC Standard 65.



# **PARAMETER MEASUREMENT INFORMATION**

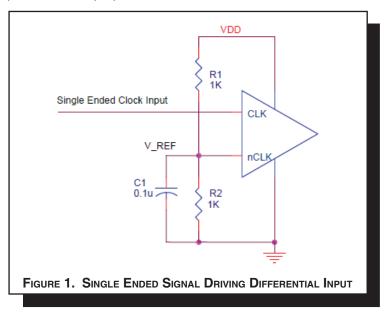


# **APPLICATION** INFORMATION

#### WIRING THE DIFFERENTIAL INPUT TO ACCEPT SINGLE ENDED LEVELS

*Figure 1* shows how the differential input can be wired to accept single ended levels. The reference voltage V\_REF =  $V_{DD}/2$  is generated by the bias resistors R1, R2 and C1. This bias circuit should be located as close as possible to the input pin. The ratio

of R1 and R2 might need to be adjusted to position the V\_REF in the center of the input voltage swing. For example, if the input clock swing is only 2.5V and  $V_{DD} = 3.3V$ , V\_REF should be 1.25V and R2/R1 = 0.609.



#### **RECOMMENDATIONS FOR UNUSED INPUT AND OUTPUT PINS**

## INPUTS:

#### **CLK INPUT:**

For applications not requiring the use of a clock input, it can be left floating. Though not required, but for additional protection, a  $1k\Omega$  resistor can be tied from the CLK input to ground.

#### CLK/nCLK INPUT:

For applications not requiring the use of the differential input, both CLK and nCLK can be left floating. Though not required, but for additional protection, a  $1k\Omega$  resistor can be tied from CLK to ground.

#### LVCMOS CONTROL PINS:

All control pins have internal pull-ups or pull-downs; additional resistance is not required but can be added for additional protection. A  $1k\Omega$  resistor can be used.

# OUTPUTS:

### LVCMOS OUTPUT:

All unused LVCMOS output can be left floating. We recommend that there is no trace attached.

DIFFERENTIAL CLOCK INPUT INTERFACE

The CLK/nCLK accepts LVDS, LVPECL, LVHSTL, SSTL, HCSL and other differential signals. Both V<sub>SWING</sub> and V<sub>OH</sub> must meet the V<sub>PP</sub> and V<sub>CMR</sub> input requirements. Figures 4A to 4E show interface examples for the CLK/nCLK input driven by the most common driver types. The input interfaces suggested here are examples only. Please consult with the vendor of the driver

1.8V Zo = 50 Ohm Zo = 50 Ohm LVHSTL LVHSTL ICS HiPerClockS LVHSTL Driver T

FIGURE 2A. CLK/NCLK INPUT DRIVEN BY LVHSTL DRIVER

component to confirm the driver termination requirements. For example in *Figure 2A*, the input termination applies for LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.

3.3V

CLK

nCLK

R2 50

R1 50

> R3 50

HiPerClockS

Inpu



Zo = 50 Ohm

Zo = 50 Ohm

 $\nabla$ 

Ν

3.3V

VPECI

3.3V LVPECL DRIVER

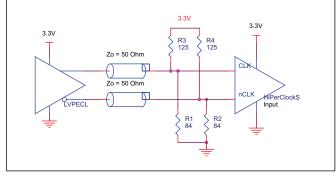


FIGURE 2C. CLK/NCLK INPUT DRIVEN BY 3.3V LVPECL DRIVER

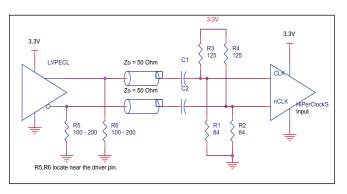


FIGURE 2E. CLK/NCLK INPUT DRIVEN BY 3.3V LVPECL DRIVER WITH AC COUPLE

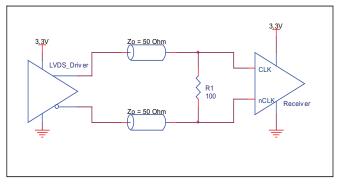


FIGURE 2D. CLK/NCLK INPUT DRIVEN BY 3.3V LVDS DRIVER



## SCHEMATIC EXAMPLE

*Figure 3* shows an application schematic example of the 87016. This schematic provides examples of input and output handling. The differential CLK1/nCLK1 input can accept various types of differential signal. This example shows the 87016 input driven by a 3.3V LVPECL driver. Additional examples for the input driven by other types of drivers are shown in the application section of this data sheet. The single ended input CLK0 is driven by a 7 $\Omega$ 

LVMCOS driver through series termination. The 87016 outputs are LVCMOS drivers. Series termination is shown in this schematic. Additional LVCMOS termination approaches are shown in the LVCMOS Termination Application Note.

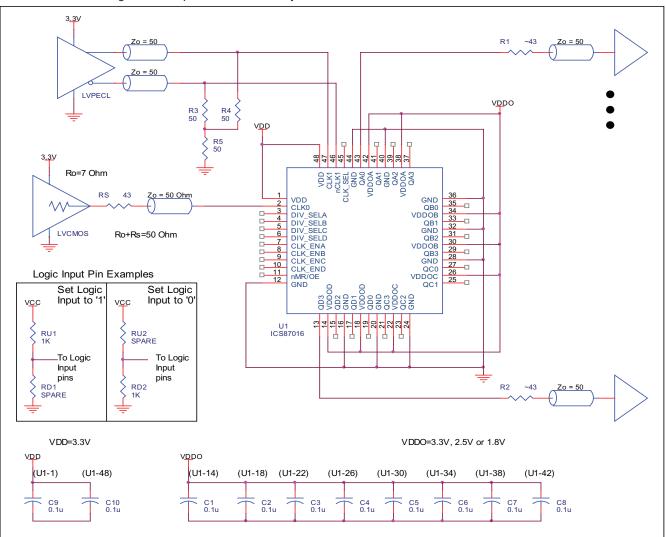


FIGURE 3. APPLICATION SCHEMATIC EXAMPLE

# **R**ELIABILITY INFORMATION

## TABLE 6. $\boldsymbol{\theta}_{\text{JA}} \text{vs.}$ Air Flow Table for 48 Lead LQFP

	0	200	500
Single-Layer PCB, JEDEC Standard Test Boards	67.8°C/W	55.9°C/W	50.1°C/W
Multi-Layer PCB, JEDEC Standard Test Boards	47.9°C/W	42.1°C/W	39.4°C/W

### TRANSISTOR COUNT

The transistor count for 87016 is: 2034

# Package Outline Drawings

The package outline drawings are appended at the end of this document and are accessible from the link below. The package information is the most current data available.

www.idt.com/us/en/document/cpt/prprg-package-outline-70-x-70-x-14-mm-tqfp-10010-form

#### TABLE 8. ORDERING INFORMATION

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
87016AYLF	ICS87016AYLF	48 Lead "Lead-Free" LQFP	tray	0°C to 85°C
87016AYLFT	ICS87016AYLF	48 Lead "Lead-Free" LQFP	tape & reel, pin 1 orientation: EIA-481-C	0°C to 85°C
87016AYLF/W	ICS87016AYLF	48 Lead "Lead-Free" LQFP	tape & reel, pin 1 orientation EIA-481-D	0°C to 85°C
			tape & reel, pin 1 orientation EIA-481-D	

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

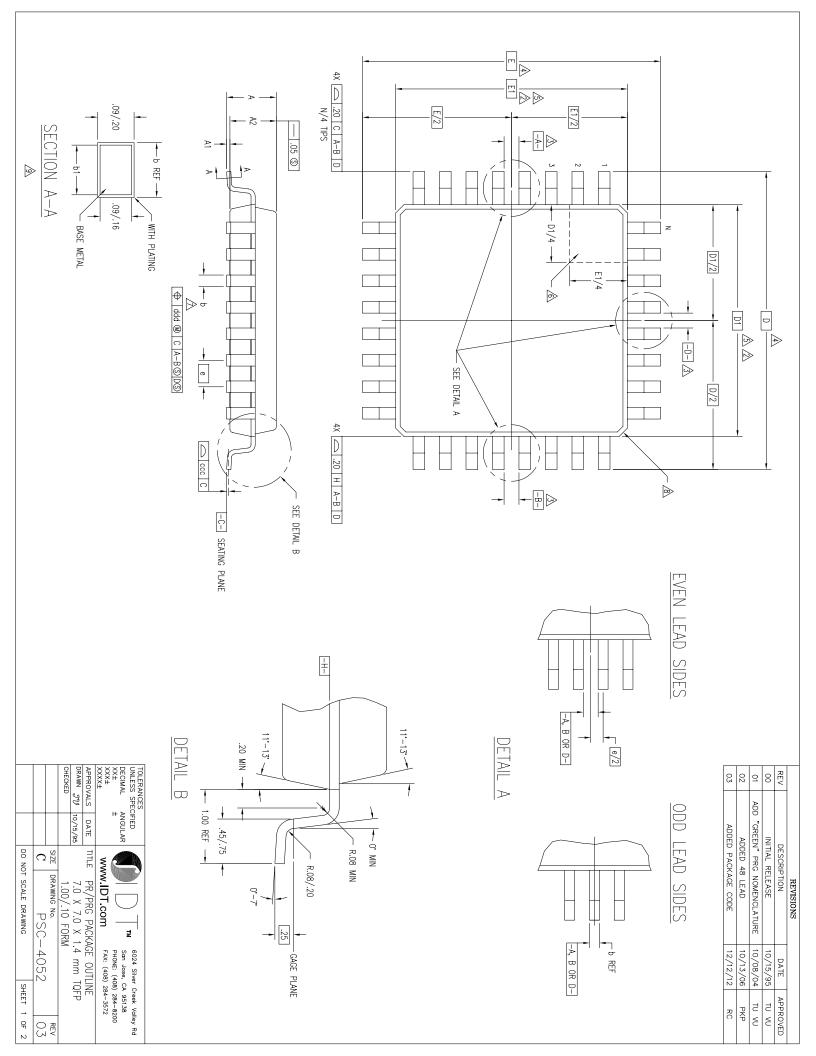
### TABLE 9. PIN 1 ORIENTATION IN TAPE AND REEL PACKAGING

Part Number Suffix	Pin 1 Orientation	Illustration
8	Quadrant 1 (EIA-481-C)	Conset FIN 1 OPENIATION CARRER TAPE TOPSDE Round Sprocise Holes)
W	Quadrant 2 (EIA-481-D)	Consct PIN 1 ORIENTATION CARRER TAPE TOPSDE (Round Sprocket Holes)

REVISION HISTORY SHEET						
Rev	Table	Page	Description of Change	Date		
A	T5A, T5B, T5C	6, 7, 8	AC Characteristics Table - corrected the first line in the Notes section, from "All parameters measured at 150MHz" to 250MHz.	7/31/02		
А			Revised part description title from "Differential-to-LVCMOS Clock Generator" to "LVCMOS Clock Generator".	8/9/02		
	T5A & T5B	6&7	AC Characteristics Table - switched prop delay values for CLK0 and CLK1, nCLK1.	5/05/03		
A		12	Added Differential Clock Input Interface section. Updated format.			
A		1	Modified Block Diagram, corrected latch block.	6/4/03		
Α		12	Added Schematic Example	12/10/04		
А	T8	1 10 15	Features Section - added Lead-Free bullet. Application Section - added <i>Recommendations for Unused Input and Output Pins.</i> Ordering Information Table - add Lead-Free part number, marking and note.	2/28/06		
А	Т8	15 15 17	Updated datasheet's header/footer with IDT from ICS. Removed ICS prefix from Part/Order Number column. Added Contact Page.			
в	T4B	4	LVCMOS DC Characteristics Table - corrected typo for 1.8V $V_{OH}$ min. spec from $V_{DD}$ - 0.45 to $V_{DDOx}$ - 0.45.			
С	Т8	1 15	Updated datasheet format. Features section - removed reference to leaded device. Ordering Information - removed leaded devices - PDN CQ-13-02.	1/12/15		
С	Т9	15	Added Pin 1 Orientation in Tape and Reel Packaging Table.	6/26/15		

Updated Package Outline Drawings section; added link.

01/21/20



EXACT SHAPE OF EACH CORNER IS OPTIONAL THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .10 AND .25 mm FROM THE LEAD TIP ALL DIMENSIONS ARE IN MILLIMETERS THIS OUTLINE CONFORMS TO JEDEC PUBLICATION 95 REGISTRATION MS-026, VARIATIONS BBA & BBC.	DATUMS <u>A-B</u> AND <u>-D-</u> TO BE DETERMINED AT DATUM PLANE <u>-H-</u> DIMENSIONS D AND E ARE TO BE DETERMINED AT SEATING PLANE <u>-C-</u> DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTRUSION IS .25 mm PER SIDE. D1 AND E1 ARE MAXIMUM BODY SIZE DIMENSIONS INCLUDING MOLD MISMATCH DETAILS OF PIN 1 IDENTIFIER IS OPTIONAL BUT MUST BE LOCATED WITHIN THE ZONE INDICATED DIMENSION & DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION IS .08 mm IN EXCESS OF THE 6 DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT.	1.35   1.40   1.45   A2   1.35   1.40   1     9.00   BSC   4   D   9.00   BSC   1     9.00   BSC   5,2   D1   7.00   BSC   1     3.0   .30   .37   .45   7   6   .17   .20   8     .30   .37   .45   7   6   .17   .22   .2   .20	PR/PRG32 PR/PRG32 PR/PRG32 PR/PRG48 PR/PRG
TOLERANCES UNLESS SPECIFIED DECIMAL XXX± XXX± APPROVALS Image: Construction of the sector of the s	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		REVISIONS REVISIONS NITIAL RELEASE 01 ADD "GREEN" PRG NOMENCLATURE 10/15/95 TU VU 02 ADDED 48 LEAD 10/13/06 PKP 03 ADDED PACKAGE CODE 12/12/12 RC N N N N N N N N N N N N N

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